

# IRFR4620PbF IRFU4620PbF

HEXFET® Power MOSFET

## **Applications**

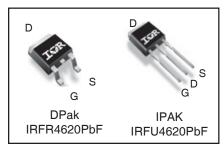
- High Efficiency Synchronous Rectification in SMPS
- Uninterruptible Power Supply
- High Speed Power Switching
- Hard Switched and High Frequency Circuits

# G

V <sub>DSS</sub>		200V
R <sub>DS(on)</sub>	typ.	$64 \mathrm{m}\Omega$
	max.	78m $\Omega$
I <sub>D</sub>		24A

### **Benefits**

- Improved Gate, Avalanche and Dynamic dV/dt Ruggedness
- Fully Characterized Capacitance and Avalanche SOA
- Enhanced body diode dV/dt and dI/dt Capability
- Lead-Free



G	D	S
Gate	Drain	Source

# **Absolute Maximum Ratings**

Symbol	Parameter	Max.	Units
I <sub>D</sub> @ T <sub>C</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V	24	
I <sub>D</sub> @ T <sub>C</sub> = 100°C	Continuous Drain Current, V <sub>GS</sub> @ 10V	17	Α
I <sub>DM</sub>	Pulsed Drain Current ①	100	
$P_D @ T_C = 25^{\circ}C$	Maximum Power Dissipation	144	W
	Linear Derating Factor	0.96	W/°C
V <sub>GS</sub>	Gate-to-Source Voltage	± 20	V
dv/dt	Peak Diode Recovery ③	54	V/ns
$T_J$	Operating Junction and	-55 to + 175	
T <sub>STG</sub>	Storage Temperature Range		°C
	Soldering Temperature, for 10 seconds	300	
	(1.6mm from case)		

### **Avalanche Characteristics**

E <sub>AS (Thermally limited)</sub>	Single Pulse Avalanche Energy ©	113	mJ
I <sub>AR</sub>	Avalanche Current ①	See Fig. 14, 15, 22a, 22b,	Α
E <sub>AR</sub>	Repetitive Avalanche Energy ①		mJ

### **Thermal Resistance**

Symbol	Parameter	Тур.	Max.	Units
$R_{\theta JC}$	Junction-to-Case ®		1.045	
$R_{\theta JA}$	Junction-to-Ambient (PCB Mount) ⑦		50	°C/W
$R_{\theta JA}$	Junction-to-Ambient		110	

### ORDERING INFORMATION:

See detailed ordering and shipping information on the last page of this data sheet.

# Static @ T<sub>J</sub> = 25°C (unless otherwise specified)

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	200			٧	$V_{GS} = 0V, I_D = 250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_{J}$	Breakdown Voltage Temp. Coefficient		0.23		V/°C	Reference to 25°C, I <sub>D</sub> = 5mA①
R <sub>DS(on)</sub>	Static Drain-to-Source On-Resistance		64	78	$m\Omega$	$V_{GS} = 10V, I_D = 15A  ext{ }  ext$
$V_{GS(th)}$	Gate Threshold Voltage	3.0		5.0	٧	$V_{DS} = V_{GS}$ , $I_D = 100\mu A$
I <sub>DSS</sub>	Drain-to-Source Leakage Current			20		$V_{DS} = 200V, V_{GS} = 0V$
				250	μA	$V_{DS} = 200V, V_{GS} = 0V, T_{J} = 125^{\circ}C$
I <sub>GSS</sub>	Gate-to-Source Forward Leakage			100	nΛ	V <sub>GS</sub> = 20V
	Gate-to-Source Reverse Leakage			-100	nA	$V_{GS} = -20V$
$R_{G(int)}$	Internal Gate Resistance	_	2.6		Ω	

# Dynamic @ T<sub>J</sub> = 25°C (unless otherwise specified)

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
gfs	Forward Transconductance	37			S	$V_{DS} = 50V, I_{D} = 15A$
$Q_g$	Total Gate Charge		25	38		I <sub>D</sub> = 15A
$Q_{gs}$	Gate-to-Source Charge		8.2		nC	$V_{DS} = 100V$
$Q_{gd}$	Gate-to-Drain ("Miller") Charge		7.9		I IIC	V <sub>GS</sub> = 10V ④
Q <sub>sync</sub>	Total Gate Charge Sync. (Q <sub>g</sub> - Q <sub>gd</sub> )		17			$I_D = 15A, V_{DS} = 0V, V_{GS} = 10V$
t <sub>d(on)</sub>	Turn-On Delay Time		13.4			V <sub>DD</sub> = 130V
t <sub>r</sub>	Rise Time		22.4		no	I <sub>D</sub> = 15A
$t_{d(off)}$	Turn-Off Delay Time		25.4		ns	$R_G = 7.3\Omega$
t <sub>f</sub>	Fall Time		14.8			V <sub>GS</sub> = 10V ④
C <sub>iss</sub>	Input Capacitance		1710			$V_{GS} = 0V$
C <sub>oss</sub>	Output Capacitance		125			$V_{DS} = 50V$
C <sub>rss</sub>	Reverse Transfer Capacitance		30		рF	f = 1.0MHz (See Fig.5)
C <sub>oss</sub> eff. (ER)	Effective Output Capacitance (Energy Related)®		113			$V_{GS} = 0V$ , $V_{DS} = 0V$ to 160V $(See Fig.11)$
	Effective Output Capacitance (Time Related)®		317			$V_{GS} = 0V, V_{DS} = 0V \text{ to } 160V  $

# **Diode Characteristics**

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
I <sub>S</sub>	Continuous Source Current			24		MOSFET symbol
	(Body Diode)			24	Α	showing the
I <sub>SM</sub>	Pulsed Source Current			100	^	integral reverse
	(Body Diode) ①			100		p-n junction diode.
$V_{SD}$	Diode Forward Voltage			1.3	٧	$T_J = 25^{\circ}C, I_S = 15A, V_{GS} = 0V \oplus$
t <sub>rr</sub>	Reverse Recovery Time		78		no	$T_J = 25^{\circ}C$ $V_R = 100V$ ,
			99		ns	$T_J = 125^{\circ}C$ $I_F = 15A$
Q <sub>rr</sub>	Reverse Recovery Charge		294		~~	$T_J = 25^{\circ}C$ di/dt = 100A/ $\mu$ s $\textcircled{9}$
			432			$T_J = 125^{\circ}C$
I <sub>RRM</sub>	Reverse Recovery Current		7.6		Α	$T_J = 25^{\circ}C$
t <sub>on</sub>	Forward Turn-On Time	Intrins	ic turn-	on time	is neg	ligible (turn-on is dominated by LS+LD)

2 www.irf.com

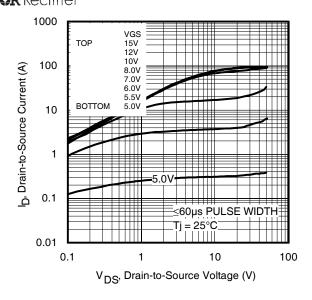


Fig 1. Typical Output Characteristics

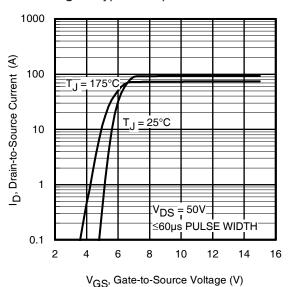
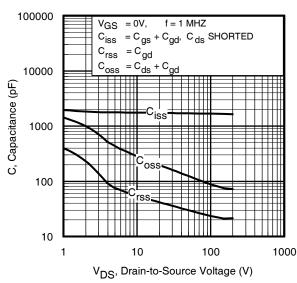


Fig 3. Typical Transfer Characteristics



**Fig 5.** Typical Capacitance vs. Drain-to-Source Voltage www.irf.com

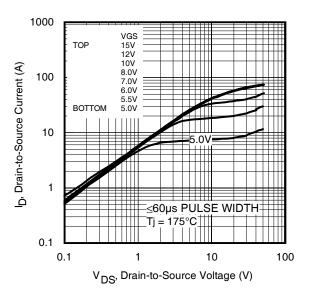


Fig 2. Typical Output Characteristics

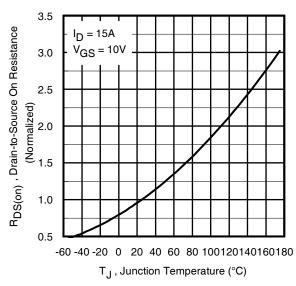


Fig 4. Normalized On-Resistance vs. Temperature

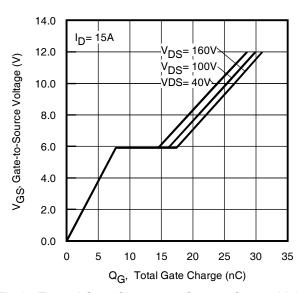


Fig 6. Typical Gate Charge vs. Gate-to-Source Voltage

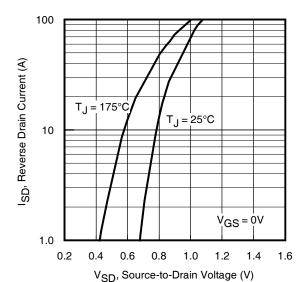
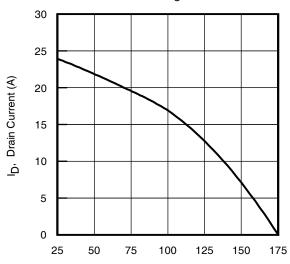
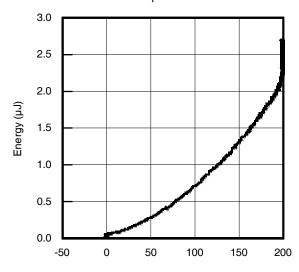


Fig 7. Typical Source-Drain Diode Forward Voltage



T<sub>C</sub> , Case Temperature (°C) **Fig 9.** Maximum Drain Current vs.

Case Temperature



 $\label{eq:VDS} \text{V}_{DS,} \text{ Drain-to-Source Voltage (V)} \\ \textbf{Fig 11.} \ \, \textbf{Typical C}_{OSS} \ \, \textbf{Stored Energy} \\$ 

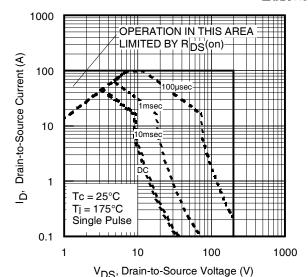


Fig 8. Maximum Safe Operating Area

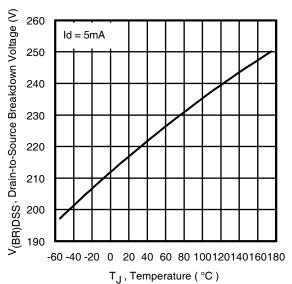


Fig 10. Drain-to-Source Breakdown Voltage

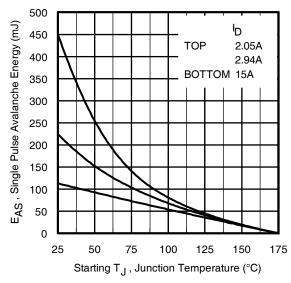


Fig 12. Maximum Avalanche Energy vs. DrainCurrent www.irf.com

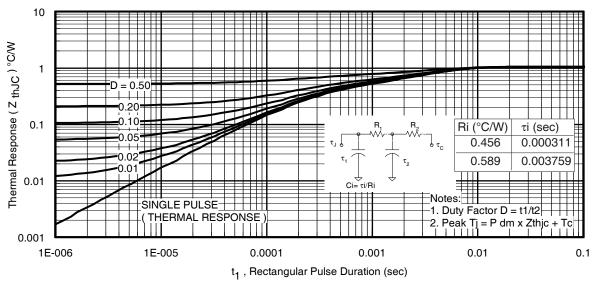


Fig 13. Maximum Effective Transient Thermal Impedance, Junction-to-Case

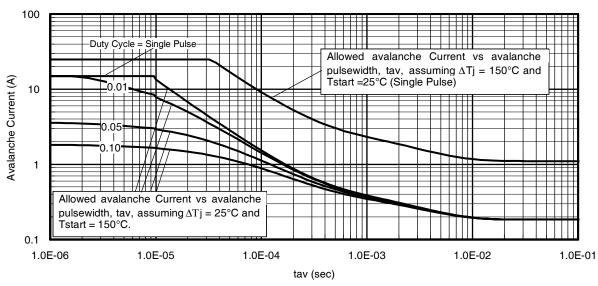


Fig 14. Typical Avalanche Current vs. Pulsewidth

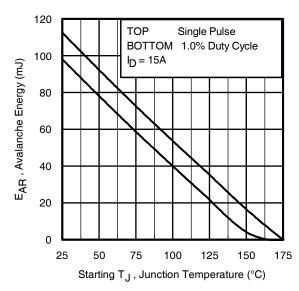


Fig 15. Maximum Avalanche Energy vs. Temperature

Notes on Repetitive Avalanche Curves , Figures 14, 15: (For further info, see AN-1005 at www.irf.com)

- 1. Avalanche failures assumption:
  - Purely a thermal phenomenon and failure occurs at a temperature far in excess of  $T_{jmax}$ . This is validated for every part type.
- 2. Safe operation in Avalanche is allowed as long asT<sub>imax</sub> is not exceeded.
- 3. Equation below based on circuit and waveforms shown in Figures 16a, 16b.
- 4.  $P_{D (ave)}$  = Average power dissipation per single avalanche pulse.
- BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
- 6. I<sub>av</sub> = Allowable avalanche current.
- 7.  $\Delta T$  = Allowable rise in junction temperature, not to exceed  $T_{jmax}$  (assumed as 25°C in Figure 14, 15).

t<sub>av =</sub> Average time in avalanche.

D = Duty cycle in avalanche =  $t_{av} \cdot f$ 

 $Z_{th,JC}(D, t_{av})$  = Transient thermal resistance, see Figures 13)

$$\begin{split} P_{D \text{ (ave)}} &= 1/2 \text{ ( } 1.3 \cdot \text{BV} \cdot \text{I}_{av} \text{)} = \triangle \text{T/ Z}_{thJC} \\ I_{av} &= 2\triangle \text{T/ [} 1.3 \cdot \text{BV} \cdot \text{Z}_{th} \text{]} \\ E_{AS \text{ (AR)}} &= P_{D \text{ (ave)}} \cdot t_{av} \end{split}$$

IRFR/U4620PbF

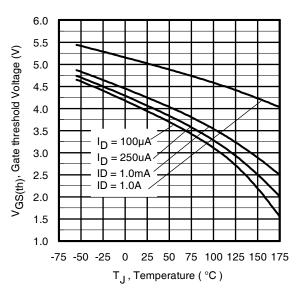


Fig 16. Threshold Voltage vs. Temperature

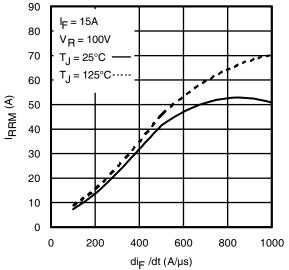
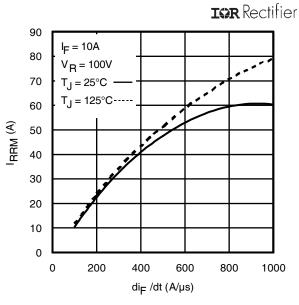


Fig. 18 - Typical Recovery Current vs. dif/dt



International

Fig. 17 - Typical Recovery Current vs. di<sub>f</sub>/dt

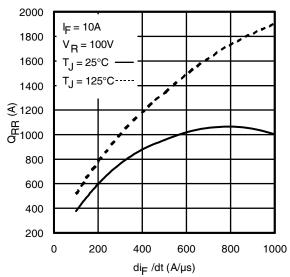


Fig. 19 - Typical Stored Charge vs. dif/dt

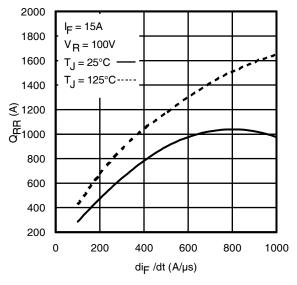


Fig. 20 - Typical Stored Charge vs. dif/dt

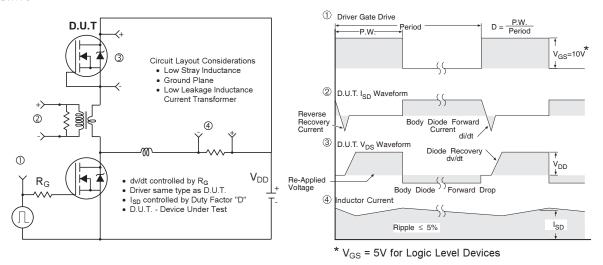


Fig 21. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs

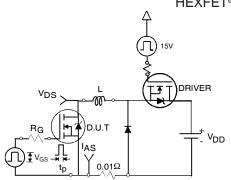


Fig 22a. Unclamped Inductive Test Circuit

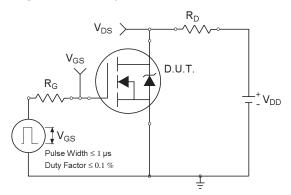


Fig 23a. Switching Time Test Circuit

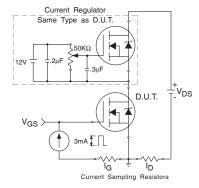


Fig 24a. Gate Charge Test Circuit

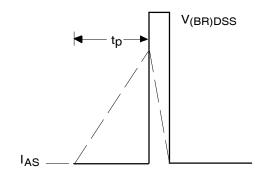


Fig 22b. Unclamped Inductive Waveforms

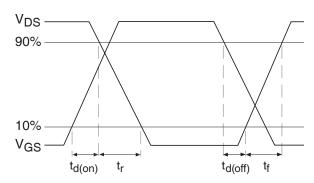


Fig 23b. Switching Time Waveforms

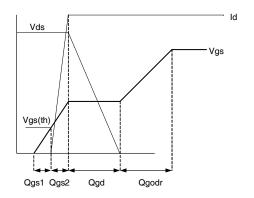
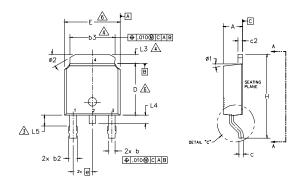
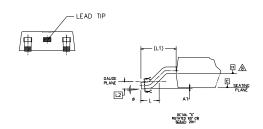


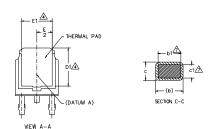
Fig 24b. Gate Charge Waveform

# D-Pak (TO-252AA) Package Outline

Dimensions are shown in millimeters (inches)







### NOTES:

- 1.- DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
- 2.- DIMENSION ARE SHOWN IN INCHES [MILLIMETERS].
- ⚠- LEAD DIMENSION UNCONTROLLED IN L5.
- A- DIMENSION D1, E1, L3 & b3 ESTABLISH A MINIMUM MOUNTING SURFACE FOR THERMAL PAD.
- 5.- SECTION C-C DIMENSIONS APPLY TO THE FLAT SECTION OF THE LEAD BETWEEN .005 AND 0.10 [0.13 AND 0.25] FROM THE LEAD TIP.
- ⚠— DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED .005 [0.13] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY.
- DIMENSION 61 & c1 APPLIED TO BASE METAL ONLY.
- ♠ DATUM A & B TO BE DETERMINED AT DATUM PLANE H.
- 9,- OUTLINE CONFORMS TO JEDEC OUTLINE TO-252AA.

S			Ŋ		
М В О	MILLIM	ETERS	INCI	HES	NOTES
L	MIN.	MAX.	MIN.	MAX.	S
Α	2.18	2.39	.086	.094	
A1	-	0.13	-	.005	
b	0.64	0.89	.025	.035	
ь1	0.65	0.79	.025	.031	7
b2	0,76	1,14	.030	.045	
b3	4.95	5.46	.195	.215	4
С	0.46	0.61	.018	.024	
c1	0.41	0.56	.016	.022	7
c2	0.46	0.89	.018	.035	
D	5.97	6.22	.235	.245	6
D1	5.21	-	.205	-	4
Ε	6.35	6.73	.250	.265	6
E1	4.32	-	.170	-	4
e	2.29	BSC	.090	BSC	
н	9.40	10.41	.370	.410	
L	1.40	1.78	.055	.070	
L1	2.74	BSC	.108	REF.	
L2	0.51	BSC	.020	BSC	
L3	0.89	1,27	.035	.050	4
L4	-	1.02	-	.040	
L5	1,14	1,52	.045	.060	3
ø	0.	10"	0.	10*	
ø1	0,	15*	0,	15*	
ø2	25*	35*	25*	35*	

### LEAD ASSIGNMENTS

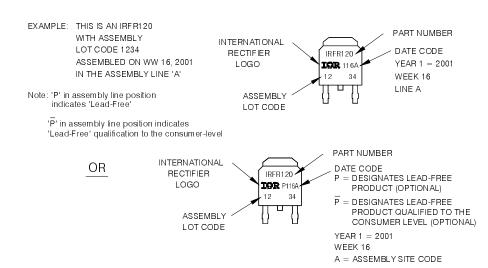
### HEXFET

- 1.- GATE 2.- DRAIN
- 3.- SOURCE
- 4.- DRAIN

### IGBT & CoPAK

- 1.- GATE
- 2.- COLLECTOR 3.- EMITTER
- 4.- COLLECTOR

# D-Pak (TO-252AA) Part Marking Information

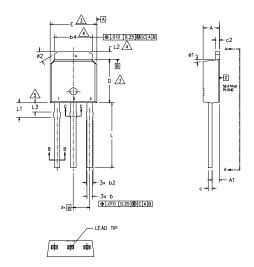


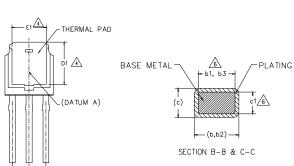
Note: For the most current drawing please refer to IR website at http://www.irf.com/package/

VIEW A-A

# I-Pak (TO-251AA) Package Outline

Dimensions are shown in millimeters (inches)





### NOTES:

- 1.- DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
- 2.- DIMENSION ARE SHOWN IN INCHES [MILLIMETERS].
- ⚠ DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED .005 [0.13] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY.
- 4- THERMAL PAD CONTOUR OPTION WITHIN DIMENSION 64, L2, E1 & D1.
- \$- LEAD DIMENSION UNCONTROLLED IN L3.
- ⚠- DIMENSION 61, 63 & c1 APPLY TO BASE METAL ONLY.
- 7.- OUTLINE CONFORMS TO JEDEC OUTLINE TO-251AA (Date 06/02).
- 8. CONTROLLING DIMENSION: INCHES,

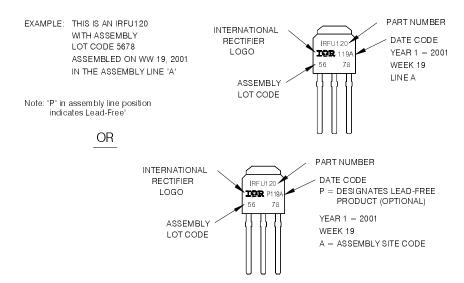
S Y M		Ŋ			
B	MILLIM	ETERS	INC	HES	O T E S
L	MIN.	MAX.	MIN.	MAX.	S
Α	2.18	2.39	.086	.094	
A1	0.89	1,14	.035	.045	
ь	0.64	0.89	.025	.035	
b1	0.65	0.79	.025	.031	6
ь2	0.76	1.14	.030	.045	
b3	0.76	1.04	.030	.041	6
b4	4.95	5.46	,195	.215	4
С	0.46	0.61	.018	.024	
c1	0.41	0.56	.016	.022	6
c2	0.46	0.89	.018	.035	
D	5.97	6.22	.235	.245	3
D1	5.21	-	.205	-	4
E	6.35	6.73	.250	.265	3
E1	4.32	-	.170	-	4
e	2.29	BSC	.090	BSC	
L	8.89	9.65	.350	.380	
L1	1.91	2.29	.045	.090	
L2	0.89	1.27	.035	.050	4
L3	1,14	1.52	.045	.060	5
ø1	0.	15*	0,	15*	
ø2	25°	35*	25*	35*	

### LEAD ASSIGNMENTS

### <u>HEXFET</u>

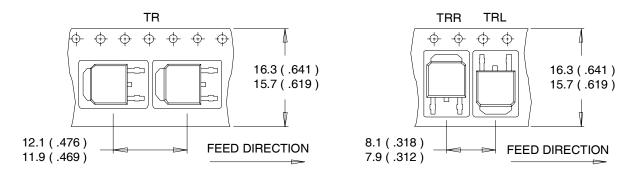
- 1.- GATE
- 2.- DRAIN 3.- SOURCE
- 4.- DRAIN

# I-Pak (TO-251AA) Part Marking Information



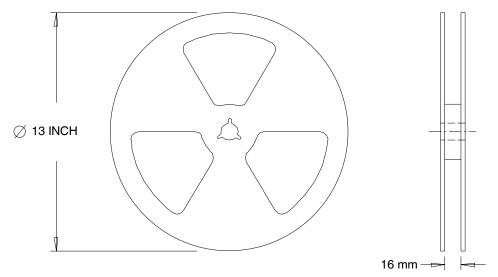
# D-Pak (TO-252AA) Tape & Reel Information

Dimensions are shown in millimeters (inches)



### NOTES:

- 1. CONTROLLING DIMENSION: MILLIMETER.
- 2. ALL DIMENSIONS ARE SHOWN IN MILLIMETERS (INCHES).
- 3. OUTLINE CONFORMS TO EIA-481 & EIA-541.



### NOTES:

1. OUTLINE CONFORMS TO EIA-481.

Orderable part number	Package Type	Standar	Standard Pack		
-		Form	Quantity		
IRFR4620PbF	D-PAK	Tube/Bulk	75		
IRFR4620TRPbF	D-PAK	Tape and Reel	2000		
IRFU4620PbF	I-PAK	Tube/Bulk	75		

### Qualification Information<sup>†</sup>

Qualification level	Industrial ††			
Qualification level	(per JEDEC JESD47F <sup>†††</sup> guidelines)			
	Comments: This family of products has passed JEDEC's Industrial qualification. IR's Consumer qualification level is granted by extension of the higher Industrial level.			
	D-PAK	MSL1		
Moisture Sensitivity Level	D-I AK	(per JEDEC J-STD-020D <sup>†††</sup> )		
	I-PAK	Not applicable		
RoHS Compliant	Yes			

- † Qualification standards can be found at International Rectifier's web site <a href="http://www.irf.com/product-info/reliability">http://www.irf.com/product-info/reliability</a>
- †† Higher qualification ratings may be available should the user have such requirements. Please contact your International Rectifier sales representative for further information: <a href="http://www.irf.com/whoto-call/salesrep/">http://www.irf.com/whoto-call/salesrep/</a> ††† Applicable version of JEDEC standard at the time of product release.

### Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature.
- ② Limited by  $T_{Jmax}$ , starting  $T_J=25^{\circ}C$ , L=1.0mH  $R_G=25\Omega$ ,  $I_{AS}=15A$ ,  $V_{GS}=10V$ . Part not recommended for use above this value .
- $\label{eq:loss_def} \mbox{\Large $3$} \ \ I_{SD} \leq 15A, \ di/dt \leq 634A/\mu s, \ V_{DD} \leq V_{(BR)DSS}, \ T_J \leq 175^{\circ}C.$
- ④ Pulse width  $\leq$  400 $\mu$ s; duty cycle  $\leq$  2%.

- $^{\circ}$  C<sub>oss</sub> eff. (TR) is a fixed capacitance that gives the same charging time as C<sub>oss</sub> while V<sub>DS</sub> is rising from 0 to 80% V<sub>DSS</sub>.
- © C<sub>oss</sub> eff. (ER) is a fixed capacitance that gives the same energy as C<sub>oss</sub> while V<sub>DS</sub> is rising from 0 to 80% V<sub>DSS</sub>.
- When mounted on 1" square PCB (FR-4 or G-10 Material). For recommended footprint and soldering techniques refer to application note #AN-994.

Data and specifications subject to change without notice



IR WORLD HEADQUARTERS: 233 Kansas St., El Segundo, California 90245, USA Tel: (310) 252-7105

TAC Fax: (310) 252-7903